Broadband Silicon Capacitor BBSC 0201 47nF BV11



1164. 3.01

General description

BBSC Capacitor targets Optical communication system such as ROSA/TOSA, SONET and all optoelectronics as well as High speed data system or products. The BBSC is suitable for DC blocking, feedback, coupling and bypassing applications in all broadband optoelectronics and High-speed data system. The unique technology of integrated passive device in silicon, developed by Murata Integrated Passive, offers unique performances with low insertion loss, low reflection and phase stability from 34 KHz to 40 GHz. These capacitors in ultra-deep trenches in silicon have been developed in a semiconductor process, in order to integrate trench MOS capacitor providing high capacitance value of 47 nF (for kHz–MHz range) and high frequency MIM capacitors for low capacitance value for GHz range), both in a SMT 0201 [0.8 x 0.6mm].

The BBSC capacitor provides very high stability of the capacitance over temperature, voltage variation as well as a very high reliability. BBSC capacitors have an extended operating temperature ranging from -55 to 150°C, with very low capacitance change over temperature (+70ppm/K).

<u>Assembly:</u> Flip chip or embedded applications through existing laminated packages (LGA, BGA) or rigid PCB, FR4 or flex platforms.

Finishing Bump finishing: ENIG

Copper pads optional for embedding version and SAC305 type 6 for pre-bumping version, as an optional finishing.

Key features

- Broadband performance to 40 GHz
- · Resonance free
- · Phase stability
- Insertion low < 0.3dB Typ. up to 40 GHz
- Ultra-high stability of capacitance value:
 - Temperature 70ppm/K (-55 °C to +150 °C)
 - Voltage <-0.1%/Volt
 - Negligible capacitance loss through ageing
- Low profile: 400μm, 100 μm on request

- Break down voltage: 11V
- Low leakage current
- High reliability
- High operating temperature (up to 150°C)
- Compatible with high temperature cycling during manufacturing operations (exceeding 300 °C)
- Compatible with EIA 0201 footprint

Key applications

- ROSA/TOSA
- SONET
- · High speed digital logic

- Microwave/millimetre system
- High volumetric efficiency (i.e. capacitance per unit volume)
- Broadband test equipment



Functional diagram

The next figure provides implementation set-up diagram.



Figure 1 Block Diagram

Electrical performances

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
С	Capacitance value	@+25°C	-	47	-	nF
ΔC_P	Capacitance tolerance (1)	@+25°C	-15	-	+15	%
T _{OP}	Operating temperature		-55	25	150	°C
T _{STG}	Storage temperature (2)		-70	- /	165	°C
ΔC_{T}	Capacitance temperature variation	-55 °C to 150 °C	-	70	-	ppm/K
RV _{DC}	Rated voltage (3))-)	-	3.8 ⁽⁴⁾ 3.4 ⁽⁵⁾	V _{DC}
BV	Break down voltage	@+25°C	11	-	-	V
ΔC_{RVDC}	Capacitance voltage variation	From 0 V to RV _{DC} , @+25°C	-	-	-0.1	%/V _{DC}
IR	Insulation resistor	@RV _{DC} , +25°C, 120s	-	10	-	GΩ
ESL	Equivalent Serial Inductance	@+25°C, SRF shunt mode	-	10	20	рН
ESR	Equivalent Serial Resistance	@+25°C, shunt mode	-	100	220	mOhm
Fc-3dB	Cut-off frequency at 3dB	@25°C	-	34	40	kHz
	Innertian long	@ 20 GHz, +25°C	-	0.2	-	dB
IL	Insertion loss	@ 40 GHz, +25°C	-	0.3	-	dB
RL	Return loss	Up to 40 GHz, +25°C	16	-	-	dB
ESD	HBM stress (6)	JS-001-2017	2	-	-	kV

Table 1 - Electrical performances

^{(1):} other tolerance available upon request

^{(2):} without packaging

^{(3):} Lifetime is voltage and temperature dependent, please refer to application note 'Lifetime of 3D capacitors'

^{(4): 10} years of intrinsic life time prediction at 100°C continuous operation (5): 10 years of intrinsic life time prediction at 150°C continuous operation

^{(6):} please refer to application note 'ESD Challenge in 3D Murata Integrated Passive technology'



Module S-parameters of 47nF BBSC in transmission mode

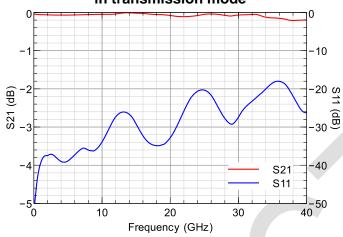


Figure 2 - 47nF BBSC measurement results (module of S-parameters)

Schematic of 47nF BBSC in transmission mode

BBSC493.547 50Ω 50Ω 50Ω

6.6-mil Rogers 4350B.

Microstrip mode – line width = 0.40 mm and gap = 0.300 mm. (nominal 50 ohm characteristic impedance).

Figure 3 – 47nF BBSC measurement schematic

Example of surface mounted 0201

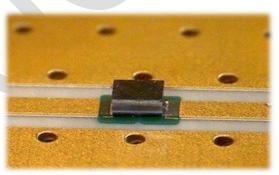


Figure 4 – micro picture of BBSC mounted on board in coplanar mode

Pinning definition

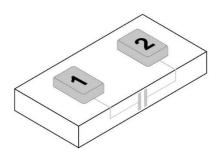


Figure 5 Pinning definition

pin #	Symbol	Coordinates X / Y
1	Signal	-225.0 / 0.0
2	Signal	225.0 / 0.0

Table 2 - Pining description. Reference (0,0) located at the centre of the die.

Ordering Information

Murata Integrated Passive Devices delivers products with AQL level II (0.65). Tighter quality levels are available upon request.

Dort number	Package				
Part number	Packaging	Finishing	Description		
939113493547-T3N	T&R _{1 000units} ⁽³⁾	ENIG ⁽²⁾	BBSC 0201 - 47nF - 2 pads - 0.8 x 0.6 x 0.40mm		
939114493547-T3N	T&R _{1 000units} ⁽³⁾	ENIG ⁽²⁾	BBSC 0201 - 47nF - 2 pads - 0.8 x 0.6 x 0.10mm		
939114493547-T5S	T&R _{5 000units} ⁽³⁾	SAC ⁽²⁾	BBSC 0201 - 47nF - 2 pads - 0.8 x 0.6 x 0.10mm		

Table 3 - Packaging and ordering information

- Other film frame carrier are possible on request
- ENIG: Min 0.1µm Au / 5µm Ni missing capacitors can reach 0.5%

Product Name Die Name		Description
BBSC493.547	UC0201547	BBSC 47nF/0201/BV:11V - 2 pads - 0.8 x 0.6 mm x 0.40mm
BBSC493.547	UC0201547	BBSC 47nF/0201/BV:11V - 2 pads - 0.8 x 0.6 mm x 0.10mm

Table 4 - Die information

Pad Metallization

This surface mounted Silicon Capacitor is delivered as standard with NiAu (ENIG(0.1µm Au / 5µm Ni)) finishing.

Other Metallization, such as SAC305 type 6 bumping, Copper, Thick Gold or Aluminum pads are possible on request.





Silicon dies are not sensitive to humidity, please refer to applications notes 'Assembly Notes' section 'Handling precautions and storage'.

Material regulation

This product is RoHS compliant at the time of publication. For further information about regulation compliancy, please ask your sales representative.

Package outline

The product is delivered as a bare silicon die.

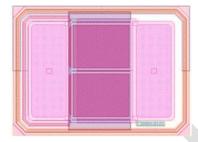


Figure 6 - Package outline drawing



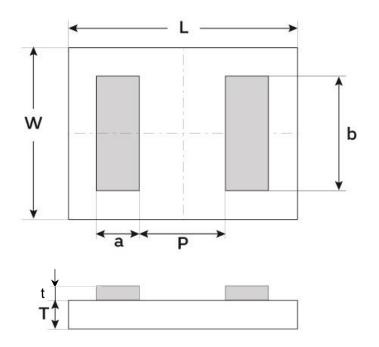


Figure 7 - Package outline drawing

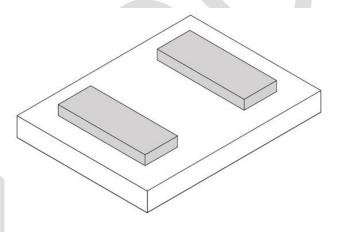


Figure 8 - Package isometric view

L (mm)	W (mm)	T (mm)	a (mm)	P (mm)	b (mm)	t (mm)
0.80 ±0.04	0.60 ±0.04	0.40 or 0.10 ±0.01	0.15	0.30	0.40	0.005 ⁽¹⁾

Table 5 - Dimensions and tolerances

(1) Standard with ENIG

Assembly

The attachment techniques recommended by Murata on the customer's substrates are fully detailed in specific documents available on our website. To assure the correct use and proper functioning of Murata capacitors please download the assembly instructions on https://www.murata.com/en-us/products/capacitor/siliconcapacitors and read them carefully.



Figure 9 Scan this QR Code to access the Murata Silicon Capacitor web page

Packaging format

Please refer to application note 'Products Storage Conditions and Shelf Life'.

Tape and Reel:

Dies are flipped in the tape cavity (bump down) with die ID located near the driving holes of the tape.

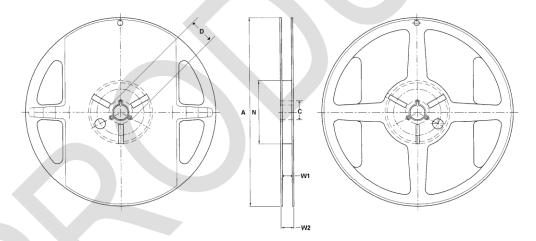


Figure 10 - Reel drawing

Tape Width	Diameter A	С	D	Hub N	W1	W2
8	178 (7 inches)	13.5	20.2	60	9.3	11.5

Table 6 – Reel dimensions (mm)



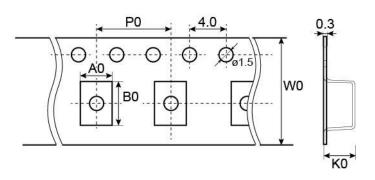


Figure 11 - Tape drawing

Cavit	Cavity dimensions		tape tape		Quantity per reel	Die thickness	
A0	В0	K0	width W0	pitch P0	per reer	T(mm)	
0.76	0.96	0.22	8	2	1 000	100µm	
0.74	0.94	0.57	8	4	1 000	400µm	

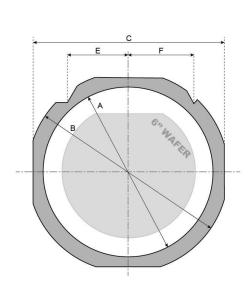
Table 7 - Tape dimensions (mm)



Film frame carrier

With UV curable dicing tape (UV performed).

Good dies are identified using the SINF electronic mapping format. No ink is added on wafer to label other dies.



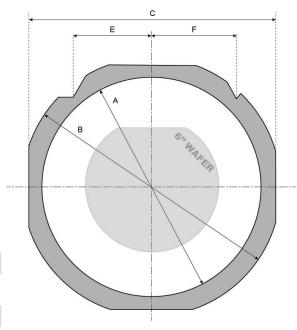


Figure 12 FF070 Frame with a 6" wafer

Figure 13 FF108 Frame with a 6" wafer

Frame Reference	Frame Style	Inside diameter A	Outside diameter B	Width C	Thickness	Pin location E	Pin location F
FF070 ⁽¹⁾	DTF-2-6-1	7.638"	8.976"	8.346"	0.048"	2.370"	2.5"
FF108 ⁽¹⁾	DTF-2-8-1	9.842"	11.653"	10.866"	0.048"	2.381"	2.5"

Table 8 - Frame dimensions (inches)

(1) or equivalent





Definitions

Data sheet status

Objective specification: This data sheet contains target or goal specifications for product development.

Preliminary specification: This data sheet contains preliminary data; supplementary data may be published later.

Product specification: This data sheet contains final product specifications.

Limiting values

Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those given in the Electrical performances sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

Revision history

Revision	Date	Description	Author
Release 1.00	2016 November 07th	Objective specification	OGA
Release 2.01	2018 June 27th	Relative to PCN	OGA
Release 3.00	2021 June 27th	Product release	OGA, DDE, SCA, SYO, DYO, LLR
Release 3.01	2022 Jan. 19th	Remove FFC packing	OGA

Disclaimer / Life support applications

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